Liquid tin sputtering experiments in the lon-surface InterAction eXperiment

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Outline

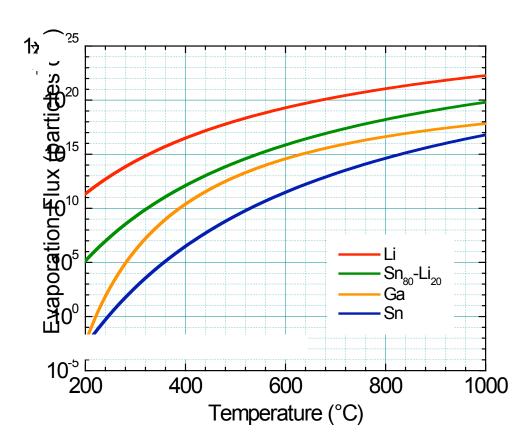
- Sn sputtering
 - Modeling
 - Experiments
- IIAX modifications/improvements
- Future work
 - Liquid sample sputtering measurements
 - Solid targets for ITER PFC support





Advantage of using liquid Sn

- Sn has an evaporative flux many orders of magnitude lower than Li
- Friendly & abundant (cheap!)
- Evaporation curves based on theory by [1] and fits from [2] and [3].





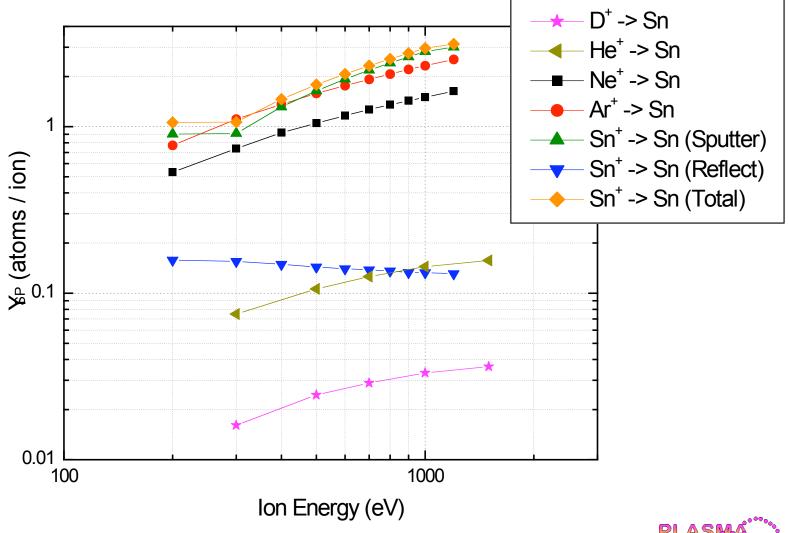
[2] M.A. Abdou, A. Ying, N.B. Morley et al., APEX Interim Report Report No. UCLA-ENG-99-206, (1999).

[3] I.A. Sheka, I.S. Chaus, T.T. Mityureva, The Chemistry of Gallium, (1966), Elsevier, Amsterdam.





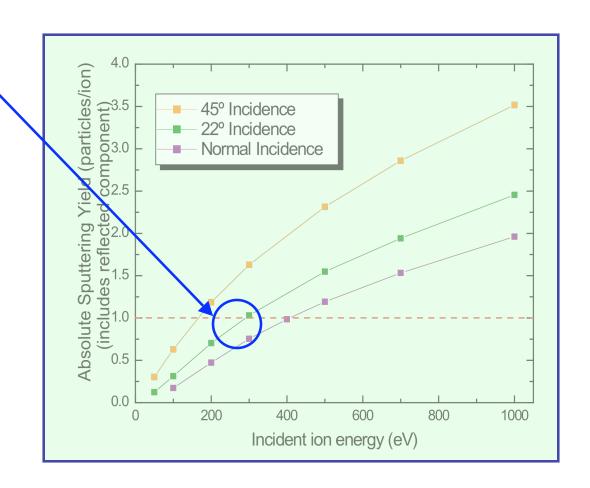
VFTRIM Simulation Results for 45° incidence on solid Sn





VFTRIM Simulations of Sn self-sputtering

- Sn ions are predicted to have a mean incident angle of 22° and an average energy of 270 eV [1] for an ARIES-AT configuration with a liquid Sn divertor
- Thus, equally important is the reduction from decreasing the angle of incidence
- Normal-incidence runs may be performed in the future to complement the oblique work done here
- D+ sputtering of liquid lithium was shown to have a drastic (10 to 1000 fold) increase as a result increasing the temperature

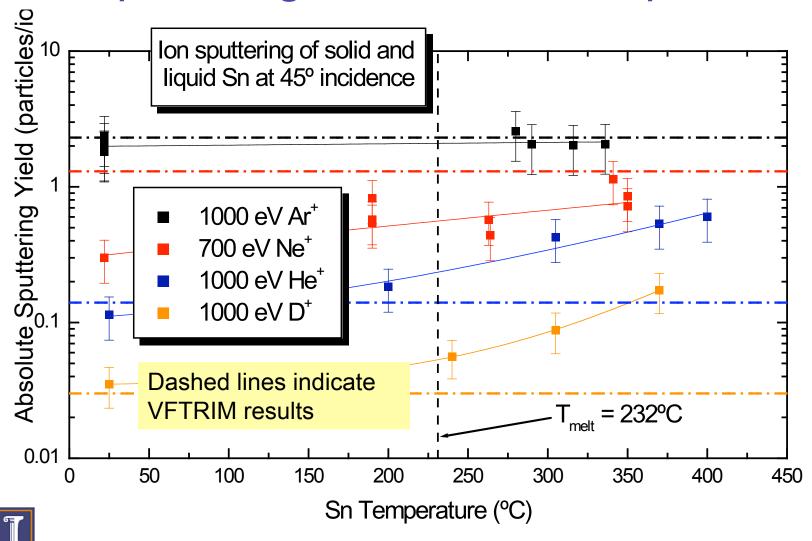


[1] Brooks, J.N. Fus. Eng. Des. **60** (2002) 515-526.





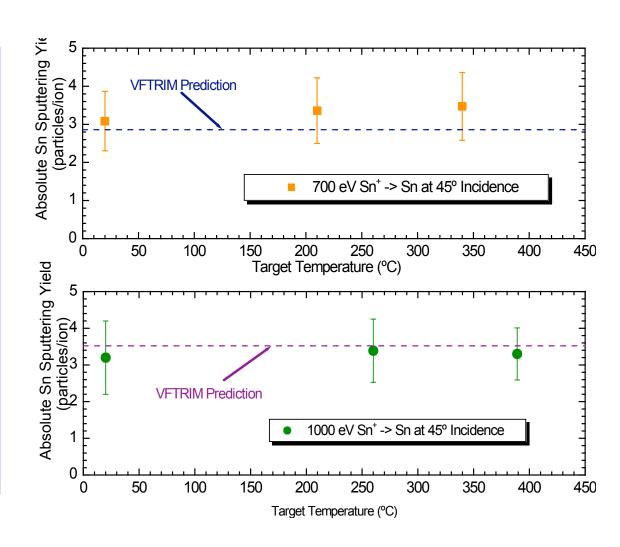
Sn sputtering results from 4 species





Sn self-sputtering measurements

- Early data indicate that Sn self-sputtering is also not significantly enhanced by temperature at least up to 400°C
- These results are similar to those for both Ne⁺ and Ar⁺ sputtering of Sn (from a temperature enhancement perspective)
- Important to note that higher temperatures may still yet show temperatureenhanced properties







Recent improvements

- Data analysis
 - Using VFTRIM "data" of sputtered particle angular distributions to help calculate how much of the ejected material intersects our monitoring crystal
- Hardware upgrades
 - Ion beam system
 - Neutral filter
 - Vertical steering near target
 - Target and QCM system
 - High temperature ability





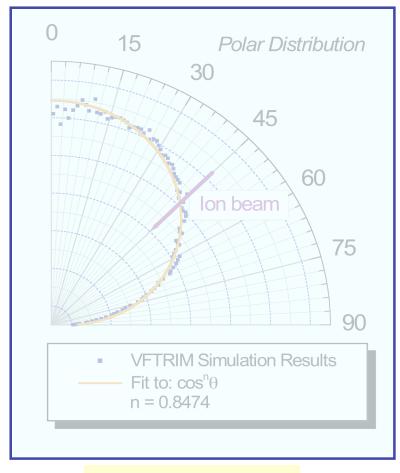
Improved estimate of "geometric factor": 1

In general...

- This "geometric factor" is just an integral over the QCO crystal surface that estimates what fraction of the sputtered material strikes (but not necessarily sticks to) the crystal
- VFTRIM simulations are now performed for each ion-target combination to generate sputtered particle distribution "data" to input into the computation of this geometric factor

(Polar angle)

- A and n are fit such that A·cosⁿθ
 fits the VFTRIM polar "data"
- Previously assumed cos¹θ polar distribution – This correction of n made little difference in the final result

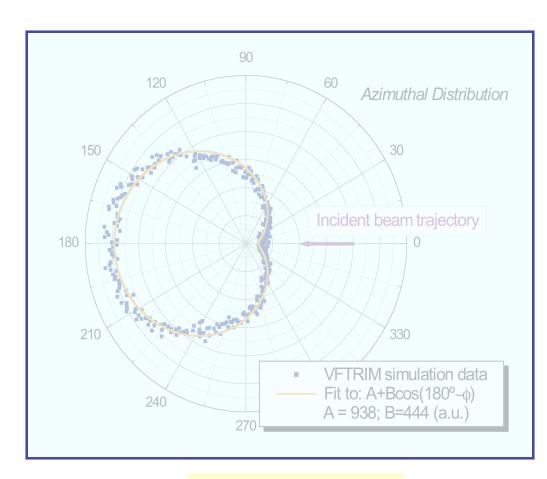


1000 eV Sn⁺ → Sn at 45° incidence





Improved estimate of "geometric factor": 2



(Azimuthal angle)

- Previously assumed azimuthal isotropy
- Significant anisotropy due to oblique incidence
- Parameters A and B are varied using A + B·cos(φ-π) to fit VFTRIM azimuthal distribution "data"

(NOTE: This function is just a guess that fits most data sets well and so doesn't necessarily have a physical interpretation)

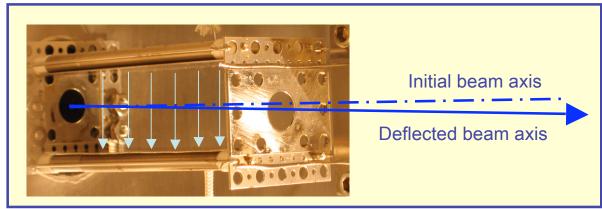


1000 eV $Sn^+ \rightarrow Sn$ at 45° incidence



Ion beam system modification Neutral filter installation

- Installed horizontal deflection plates to make 3° bend to filter neutrals
 - Previously relied on Wien filter <u>E</u>-field to bend beam followed by 10 –
 15 cm of 3.5-cm diameter tubing (along unbent beam axis)
 - Now, horizontal deflection for neutral filtering is performed after entering the main chamber to minimize neutral component
 - Unfortunately, this has degraded beam performance (as expected)







Prior target temperature was limited

- Two factors...
 - Poor thermal considerations in target/heater holder design limited target to ~550°C
 - Above ~420°C, the QCM units would fail due to being close to the hot target without active cooling
- Recent hardware upgrades to allow high temperature measurement
 - Repaired QCM head for electrically-isolated water cooling
 - Installation of new target holder
 - Goal: Reach 1000°C (Heater rated for 1200°C)





Modification to QCM head: Electrically-isolated water cooling

Benefits:

- Greatly improved crystal stability (better signal to noise ratio) at all temperatures
- Able to exceed 870°C without crystal failure with no apparent limit as of yet (heater power limit should be ~1100°C)
- Maintaining the same crystal temperature for all target temperatures
- Use of a ceramic break and deionized water maintains electrical isolation

Drawbacks:

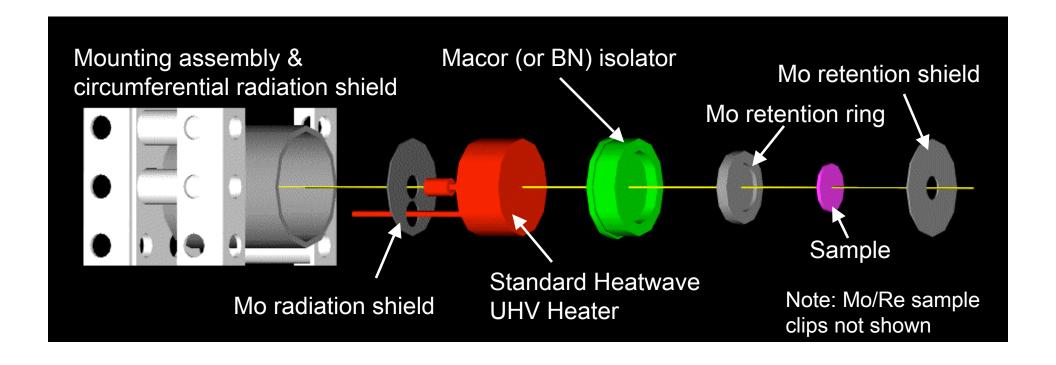
- Greatly reduced mobility of QCM head due to stiff "flexible" water lines
- Marginally degraded base pressure due to use of Swagelok fittings (low 8's versus mid 9's on a good day)





Heater & liquid sample holder redesign

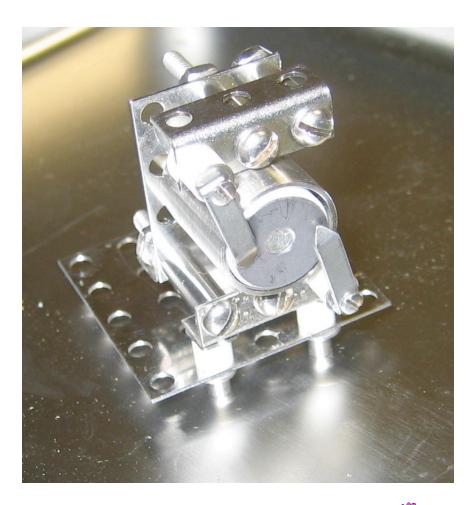
- Thermal considerations
 - Minimized thermal contact between heater/target components and mounting hardware
 - Radiation shield around circumference (SS) and behind (Mo) heater to minimize radiative losses



New sample holder construction

- Currently, only one assembly 'hard' mounted
- Goal: Several interchangeable sample assemblies
- Quick assembly replacement (through 6" CF port)
- Two samples mounted with others ready to minimize down-time
- Need:
 - Design & construction time
 - Feedthough

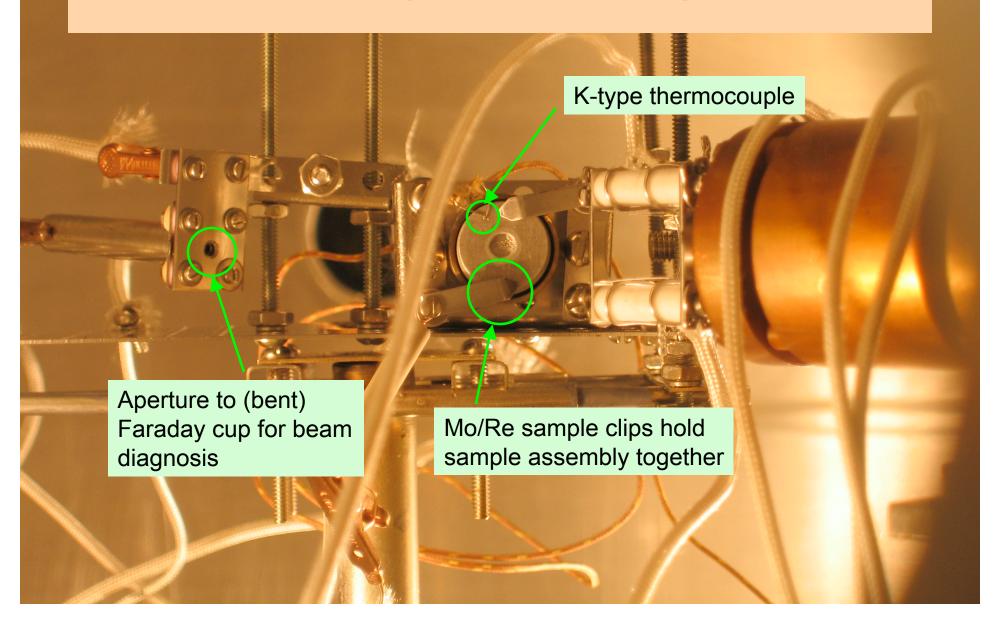
₩HV-grade plugs

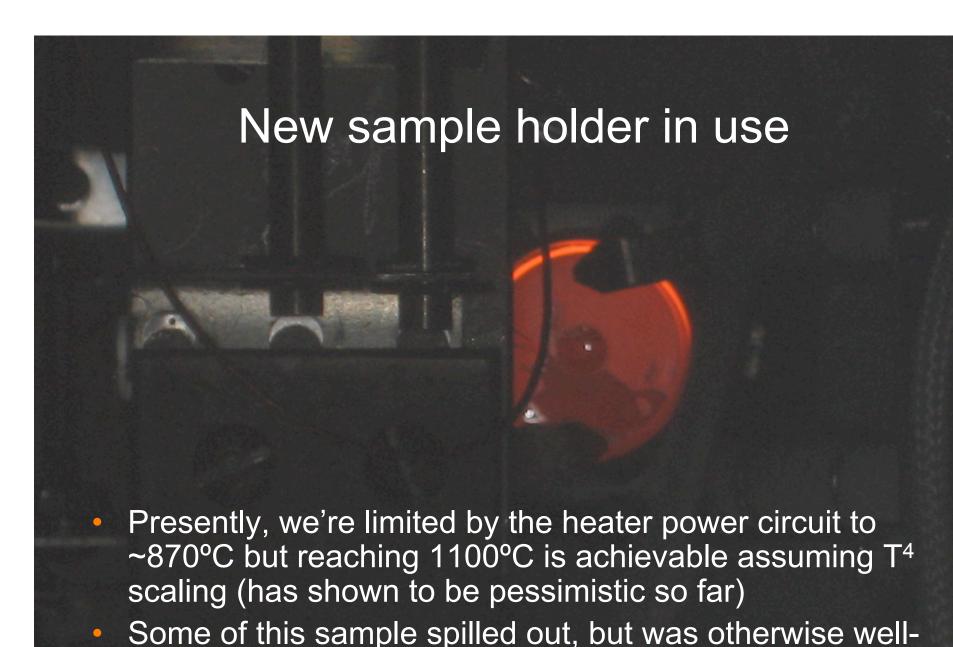






New sample holder in place





behaved and showed a beautifully-reflective surface

Summary of modifications

- With improved data analysis techniques and an improved ion beam system, our data quality is improved
- To date, hardware limitations have kept our sample temperatures at or below 400°C; since a Sn divertor's evaporation-limited temperature limit is estimated to be 1200°C^[1], higher temperature (and lower energy) measurements are needed
- IIAX hardware upgrade should allow sample temperature of at least 1100°C

[1] Brooks, J.N., *Modeling of sputtering erosion/redeposition – status and implications for fusion design.* Fus. Eng. Des., **60** (2002) p515-526.





Future Work

Near-term:

- Focus on light ion (He⁺ & D⁺) sputtering of liquid Sn at higher temperatures – up to 1000°C
- Return to heavy ion sputtering (Ne+, Ar+, and/or Sn+)
- Reduce ion energies used (ideally to 100-200 eV with use of decelerator)

Longer term:

- Temp. dep sputtering of liquid Sn & Ga
- Model apparent mass-dependence of temperature-enhanced sputtering
- Li⁺ or Sn⁺ sputtering of Mo & LM-coated Mo
- Measurement of the ionized fraction of sputtered material of PFC
- Mixed solid material sputtering relevant to ITER (W, Be, C, etc.)





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